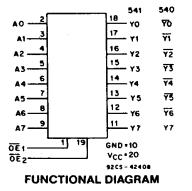
Technical Data ______ CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541





Octal Buffer/Line Drivers, 3-State

CD74AC/ACT540 - Inverting

CD74AC/ACT541 - Non-Inverting

Type Features:

Buffered inputs

 Typical propagation delay: 4.5 ns @ V_{cc} = 5 V, T_A = 25° C, C_L = 50 pF

The CD54/74AC540, -541, and CD54/74ACT540, -541 octal buffer/line drivers use the RCA ADVANCED CMOS technology. The CD54/74AC/ACT540 are inverting 3-state buffers having two active-LOW output enables. The CD54/74AC/ACT541 are non-inverting 3-state buffers having two active-LOW output enables.

The CD74AC540, -541, and CD74ACT540, -541 are supplied in 20-lead dual-in-line plastic packages (E suffix) and in 20-lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Industrial (-40 to +85°C) and Extended Industrial/Military (-55 to +125°C).

The CD54AC540, -541, and CD54ACT540, -541, available in chip form (H suffix), are operable over the -55 to $+125^{\circ}$ C temperature range.

Family Features:

- Exceeds 2-kV ESD Protection MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
- Speed of bipolar FAST®/AS/S with significantly
- reduced power consumption
- Balanced propagation delays
 AC types feature 1.5-V to 5.5-V operation and balanced
- noise immunity at 30% of the supply. • ± 24-mA output drive current
 - Fanout to 15 FAST® ICs
 - Drives 50-ohm transmission lines

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TRUTH TABLE

	CD54/74A	C/ACT540
INPUTS		OUTPUTS
OE1, OE2	Α	Y
L	L	Н
L	н	L
н	x	Z

H = High Voltage

L = Low Voltage

X = Immaterial

Z = High Impedance

TRUTH TABLE

	CD54/74AC	/ACT541
INPUTS		OUTPUTS
OE1, OE2	A	Υ
L	L	L
L	н	н
н	X	Z



CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541

MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE (V _{CC})	
DC INPUT DIODE CURRENT, I _{IK} (for V _I < -0.5 or V _I > V _{CC} + 0.5 V)	
DC OUTPUT DIODE CURRENT, I _{OK} (for V _O < -0.5 or V _O > V _{CC} + 0.5 V)	
DC OUTPUT SOURCE OR SINK CURRENT per Output Pin, I _O (for V _O > -0.5 or V _O < V _{CC} + 0.5 V) ±50 mA	
DC V _{CC} OR GROUND CURRENT (I _{CC} or I _{GND})	
PACKAGE THERMAL IMPEDANCE, θJA (see Note 1): E package	
M package	
STORAGE TEMPERATURE (T _{sta})	
LEAD TEMPERATURE (DURING SOLDERING):	
At distance 1/16 ± 1/32 in. (1.59 ± 0.79 mm) from case for 10 s maximum	
Unit inserted into PC board min. thickness 1/16 in. (1.59 mm) with solder contacting lead tips only	
* For up to 4 outputs per device: add +25 mA for each additional output	

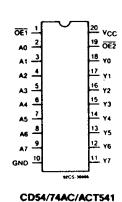
* For up to 4 outputs per device: add ±25 mA for each additional output.
 NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

RECOMMENDED OPERATING CONDITIONS:

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

QUARACTERICTIC	LIN		
CHARACTERISTIC	MIN.	MAX.	
Supply-Voltage Range, Vcc*:			1
(For T _A = Full Package-Temperature Range)		:	l l
AC Types	1.5	5.5	l v
ACT Types	4.5	5.5	V
DC Input or Output Voltage, VI, Vo	0	Vcc	V
Operating Temperature, TA:	-55	+125	°C
Input Rise and Fall Slew Rate, dt/dv			1
at 1.5 V to 3 V (AC Types)	0	50	ns/V
at 3.6 V to 5.5 V (AC Types)	0	20	ns/V
at 4.5 V to 5.5 V (ACT Types)	0	10	ns/V

*Unless otherwise specified, all voltages are referenced to ground.



TERMINAL ASSIGNMENT DIAGRAMS

	20 VCC
	19 DE2
	18 VO
	17 ¥1
	16 Y2
	15 ¥3
	13
	- 13
	12 ¥6
	11 77
\$2C5	
(744C/4C	TEAD

CD54/74AC/ACT540

Technical Data _ CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541

STATIC ELECTRICAL CHARACTERISTICS: AC Series

					AMBIENT TEMPERATURE (TA) - °C						
CHARACTERISTICS		TEST CONDITIONS		Vcc	+25		-40 to +85		-55 to +125		UNITS
		V, (V)	l _o (mA)	(Ÿ)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
High-Level Input				1.5	1.2	_	1.2		1.2	_]
Voltage	Ин			3	2.1	_	2.1	-	2.1	-	v
				5.5	3.85	-	3.85	_	3.85		
Low-Level Input				1.5	-	0.3	—	0.3		0.3	
Voltage	ViL			3	-	0.9	-	0.9	<u> </u>	0.9	v
			1	5.5	-	1.65	_	1.65		1.65	
High-Level Output			-0.05	1.5	1.4	_	1.4	-	1.4	-	
Voltage	Vон	Vin	-0.05	3	2.9		2.9	_	2.9	_	
		or	-0.05	4.5	4.4	-	. 4.4	_	4.4	—	
		VIL	-4	3	2.58	_	2.48		2.4] v
			-24	4.5	3.94	_	3.8	-	3.7]
		#, * {	-75	5.5			3.85	_	-	_]
		", "	-50	5.5	-	_			3.85]
Low-Level Output		· · · ·	0.05	1.5	_	0.1	_	0.1	-	0.1	
Voltage	Vol	VIH	0.05	3		0.1	-	0.1		0.1]
		or	0.05	4.5	-	0.1	-	0.1	_	0.1]
		VIL	12	3		0.36	_	0.44	_	0.5	v
			24	4.5	-	0.36	-	0.44	_	0.5]
		#, * {	75	5.5				1.65		_]
		<i>"````</i> }	50	5.5			_	-	—	1.65	1
Input Leakage Current	h	V _{cc} or GND		5.5		±0.1	_	±1	-	±1	μA
3-State Leakage Current	loz	V _{IH} Or									
		V _{1L} V ₀ =		5.5	_	±0.5	_	±5		±10	μA
		V _{cc} or GND									
Quiescent Supply Current, MSI	lcc	V _{cc} or GND	0	5.5	-	8	-	80	_	160	μA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation. * Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

Technical Data CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541

STATIC ELECTRICAL CHARACTERISTICS: ACT Series

CHARACTERISTICS		TEST CONDITIONS			AMBIENT TEMPERATURE (TA) - °C]
				V _{cc}	+	+25		o +85	-55 to	o +125	UNITS
		V, (V)	l _o (mA)	(V)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.]
High-Level Input Voltage	Vін			4.5 to 5.5	2		2	_	2	_	v
Low-Level Input Voltage	ViL			4.5 to 5.5		0.8	-	0.8	_	0.8	v
High-Level Output		VIH	-0.05	4.5	4.4	—	4.4	_	4.4	—	
Voltage	Vон	or ViL	-24	4.5	3.94		3.8		3.7		v
		#, * {	-75	5.5	-	—	3.85		-		
			-50	5.5		-	—	-	3.85	-	
Low-Level Output		Vін	0.05	4.5	—	0.1	—	0.1	-	0.1	
Voltage	Vol	or ViL	24	4.5		0.36		0.44	—	0.5	v I
		#. * {	75	5.5	-	—	—	1.65	_	—	
		···)	50	5.5	—	_	—	-	—	1.65	
Input Leakage Current	l,	V _{cc} or GND		5.5	-	±0.1	_	±1	-	±1	μA
3-State Leakage Current	loz	VIH or VIL Vo = Vcc or GND		5.5	_	±0.5	_	±5	_	±10	μA
Quiescent Supply Current, MSI	lcc	V _{cc} or GND	0	5.5	_	8	_	80		160	μΑ
Additional Quiescent Current per Input Pi TTL Inputs High 1 Unit Load		V _{cc} -2.1		4.5 to 5.5		2.4		2.8		3	mA

#Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation. * Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

ACT INPUT LOADING TABLE

INPUT	UNIT	LOAD
	540	541
DATA	1.42	0.5
OE1, OE2	1.3	1.3

*Unit load is ΔI_{cc} limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25°C.

Technical Data CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541

SWITCHING CHARACTERISTICS: AC Series; t,, t, = 3 ns, CL = 50 pF

				AMBIENT TEMPERATURE (TA) - °C					
CHARACTERISTICS	SYMBOL	۷ (۷۶	-40 t	o +85	-55 t	o +125	UNITS		
		(•)	MIN.	MAX.	MIN.	MAX.	1		
Propagation Delays: Data to Output AC540	tplh tphl	1.5 3.3* 5†	2.4 1.8	77 8.6 6.2	 2.4 1.7	85 9.5 6.8	ns		
AC541	tplн tphl	1.5 3.3 5	 2.8 2.1	89 9.9 7.1	 2.7 2	98 10.9 7.8	ns		
Enable, to Output to Output	tezı tezн	1.5 3.3 5	 4.6 3.1	136 16.4 10.9	 4.5 3	150 18 12	ns		
Disable to Output to Output	telz teнz	1.5 3.3 5		136 13.6 10.9	— 3.8 3	150 15 12	ns		
Power Dissipation Capacitance AC540 AC541	Сро‡			60 Typ. 60 Typ. 60 Typ. 60 Typ.		pF			
Min. (Valley) V _{он} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See Fig. 1	5		v					
Max. (Peak) VoL During Switching of Other Outputs (Output Under Test Not Switching)	Volp See Fig. 1	5	1 Typ. @ 25°C			v			
Input Capacitance	Cı	_	-	10		10	pF		
3-State Output Capacitance	Co	_	- 1	15		15	pF		

SWITCHING CHARACTERISTICS: ACT Series; L, L = 3 ns, CL = 50 pF

			AMBI	`_) - °C	1			
CHARACTERISTICS	SYMBOL	V _{cc} (V)	-40 t	o +85	-55 to	=125		
		(•)	MIN.	MAX.	MIN.	MAX.]	
Propagation Delays: Data to Output ACT540	tрін tрні	5†	1.9	6.5	1.8	7.2	ns	
ACT541	t _{PLH} tpHL	5†	2.1	7.5	2.1	8.2	ns	
Enable to Output	t _{PZL} t _{PZH}	5	3.5	12.2	3.4	13.4	ns	
Disable to Output	t _{PLZ} tpнz	5	3.5	12.2	3.4	13.4	ns	
Power Dissipation Capacitance ACT540 ACT541	Cpo§	_		Тур. Тур.			pF	
Min. (Valley) V _{он} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See Fig. 1	5		v				
Max. (Peak) Vol During Switching of Other Outputs (Output Under Test Not Switching)	V _{OLP} See Fig. 1	5	1 Typ. @ 25°C			v		
Input Capacitance	Cı	_	-	10		10	рF	
3-State Output Capacitance	Co	. —		15	_	15	pF	

*3.3 V: min. is @ 3.6 V max. is @ 3 V

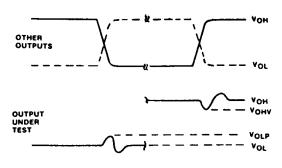
§CPD is used to determine the dynamic power consumption, per channel.

†5 V: min. is @ 5.5 V max. is @ 4.5 V For AC series, $P_D = V_{cc}^2 f_i (C_{PD} + C_L)$ For ACT series, $P_D = V_{cc}^2 f_i (C_{PD} + C_L) + V_{cc} \Delta I_{cc}$ where

 $f_i = input frequency$ CL = output load capacitance $V_{cc} =$ supply voltage.

Technical Data CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541

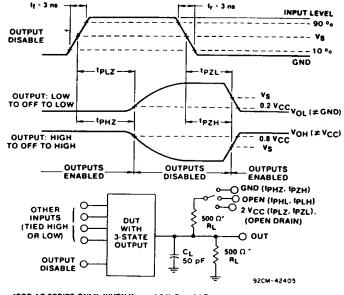
PARAMETER MEASUREMENT INFORMATION



NOTES:

- 1. VOHY AND VOLP ARE MEASURED WITH RESPECT TO A GROUND REFERENCE NEAR THE OUTPUT UNDER TEST. 2. INPUT PULSES HAVE THE FOLLOWING CHARACTERISTICS:
- PRR ≤ 1 MHz, t_f = 3 na, t_f = 3 na, SKEW 1 na. 3. R.F. FIXTURE WITH 700-MHz DESIGN RULES REQUIRED. IC SHOULD BE SOLDERED INTO TEST BOARD AND BYPASSED WITH 0.1 # CAPACITOR. SCOPE AND PROBES REQUIRE 700-MHz BANDWIDTH.

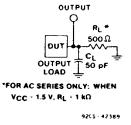
9205-42406



*FOR AC SERIES ONLY: WHEN VCC = 1.5 V, RL = 1 k\Omega

Fig. 1 - Simultaneous switching transient waveforms.

Fig. 2 - Three-state propagation delay waveforms and test circuit.



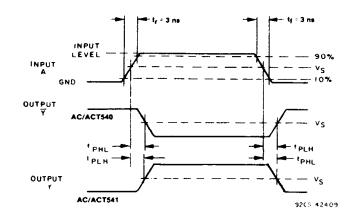


Fig. 3 - Propagation delay times and test circuit.

	CD54/74AC	CD54/74ACT
Input Level	Vcc	3 V
Input Switching Voltage, Vs	0.5 V _{cc}	1.5 V
Output Switching Voltage, Vs	0.5 V _{cc}	0.5 V _{cc}



24-Aug-2018

PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD54AC541F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54AC541F3A	Samples
CD54ACT540F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54ACT540F3A	Samples
CD54ACT541F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54ACT541F3A	Samples
CD74AC540M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC540M	Samples
CD74AC540M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM		AC540M	Samples
CD74AC540ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC540M	Samples
CD74AC541E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC541E	Samples
CD74AC541EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74AC541E	Samples
CD74AC541M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC541M	Samples
CD74AC541M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC541M	Samples
CD74AC541M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC541M	Samples
CD74AC541M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC541M	Samples
CD74AC541SM96	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	AC541SM	Samples
CD74ACT540E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT540E	Samples
CD74ACT540M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT540M	Samples
CD74ACT540M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT540M	Samples
CD74ACT540M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT540M	Samples



PACKAGE OPTION ADDENDUM

24-Aug-2018

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
CD74ACT540MG4	(1) ACTIVE	SOIC	DW	20	25	(2) Green (RoHS & no Sb/Br)	(6) CU NIPDAU	(3) Level-1-260C-UNLIM	-55 to 125	(4/5) ACT540M	Samples
CD74ACT541E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT541E	Samples
CD74ACT541EE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT541E	Samples
CD74ACT541M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT541M	Samples
CD74ACT541M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT541M	Samples
CD74ACT541M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT541M	Samples
CD74ACT541M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT541M	Samples
CD74ACT541MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT541M	Samples
CD74ACT541SM96	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT541SM	Samples
CD74ACT541SM96E4	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT541SM	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



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PACKAGE OPTION ADDENDUM

24-Aug-2018

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD54AC541, CD54ACT540, CD54ACT541, CD74AC541, CD74ACT540, CD74ACT541 :

- Catalog: CD74AC541, CD74ACT540, CD74ACT541
- Military: CD54AC541, CD54ACT540, CD54ACT541

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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Texas Instruments

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74AC540M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74AC541M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74AC541SM96	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
CD74ACT540M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74ACT541M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
CD74ACT541SM96	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

10-Aug-2016



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74AC540M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74AC541M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74AC541SM96	SSOP	DB	20	2000	367.0	367.0	38.0
CD74ACT540M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74ACT541M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74ACT541SM96	SSOP	DB	20	2000	367.0	367.0	38.0

J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

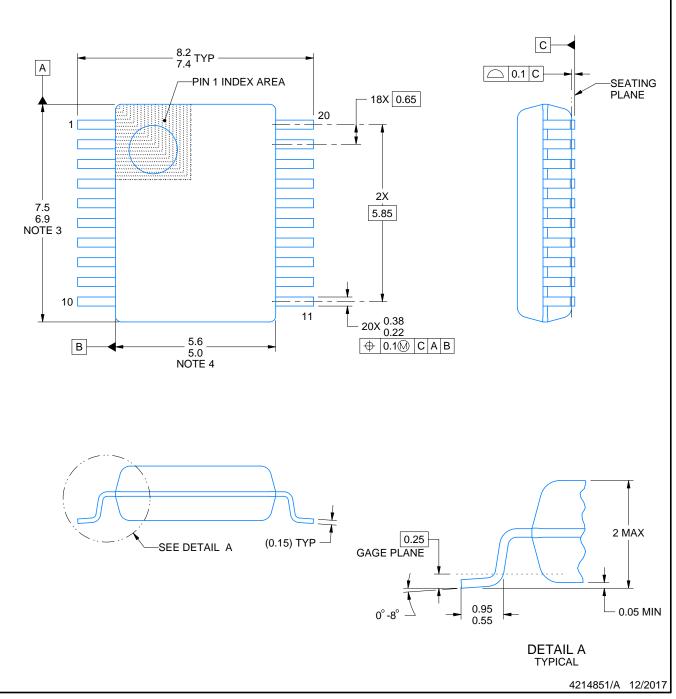
DB0020A



PACKAGE OUTLINE

TSSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.

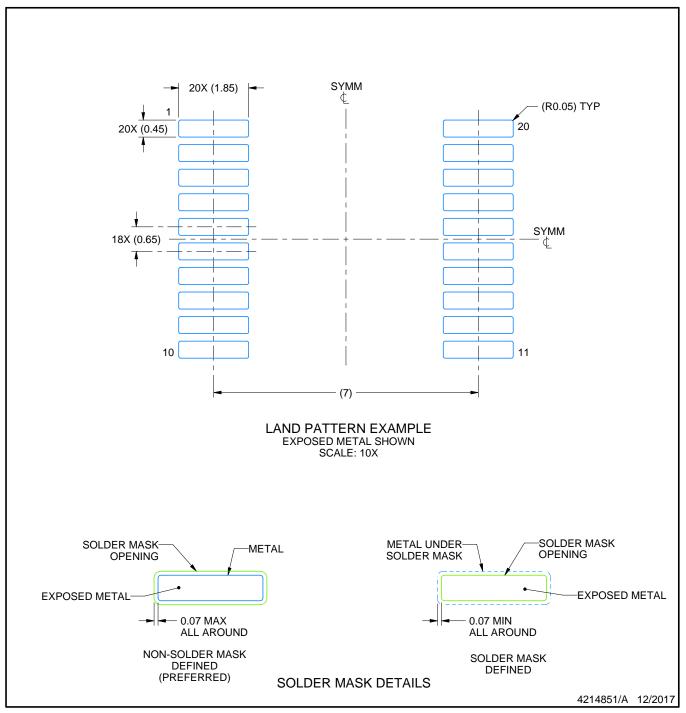


DB0020A

EXAMPLE BOARD LAYOUT

TSSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

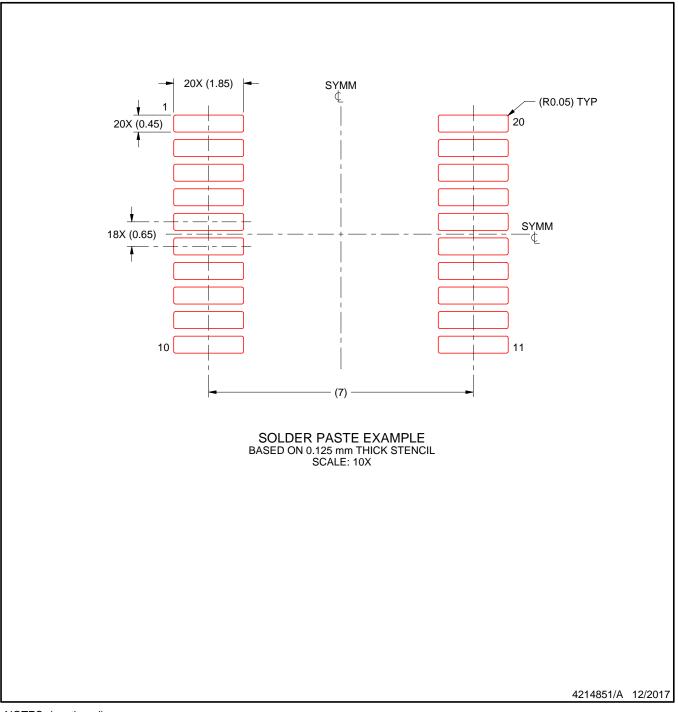


DB0020A

EXAMPLE STENCIL DESIGN

TSSOP - 2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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